

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10575706	VAANANEN ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
ANDREW LAI	2416	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	235,232,230.1,230,229	10/22/2008	T.N.
709	235,232,230	10/22/2008	T.N.
370	229,230,230.1,232,235,428	3/24/09	AL

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST text search (US- PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM_TDB)	10/22/2008	T.N.
EAST and PALM inventor search	10/22/2008	T.N.
IEEEExplore	10/22/2008	T.N.
Text search in EAST. See Search History for details	3/24/09	AL
Inventorship search in EAST. See Search History for details	3/24/09	AL
Discussion with SPE Kwang Yao regarding uniquely claimed features and allowance for the case	3/24/09	AL

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	Text search in EAST. See Interference Search History for details	3/24/09	AL